


<b>Search Notes</b>  	<b>Application/Control No.</b>  10553411	<b>Applicant(s)/Patent Under Reexamination</b>  BOSSERT ET AL.
	<b>Examiner</b>  HUY HO	<b>Art Unit</b>  2617

SEARCHED			
Class	Subclass	Date	Examiner
455	562.1,561,550.1	3/24/08	Ichieh Cheng
370	330	10/7/2008	HH

SEARCH NOTES		
Search Notes	Date	Examiner
Text search attached	3/24/08	Ichieh Cheng
EAST Search and Update from last search	10/7/2008	HH
Search Update	5/23/2009	HH
Search Update	12/2/2009	HH
Search Update	6/3/2010	HH
Search Update	1/15/2011	HH
Subject matter and allow subject matter were consulted with Primary Examiner Huy Phan, Michael Thier, Steven H. Nguyens	1/13/2011	HH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/HUY C HO/  
Examiner,Art Unit 2617